





COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

Features

- Low On-Resistance
- Low Gate Threshold Voltage V_{GS(th)} <1V
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Complementary Pair MOSFET
- Ultra-Small Surface Mount Package
- Lead Free/RoHS Compliant (Note 2)
- ESD Protected Gate to 2.5kV HBM
- "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

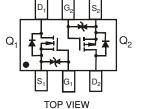
- Case: SOT-563
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020D
- Terminal Connections: See Diagram
- Terminals: Finish Matte Tin annealed over Copper leadframe.
 Solderable per MIL-STD-202, Method 208
- Marking Information: See Page 7
- Ordering Information: See Page 7
- Weight: 0.006 grams (approximate)

SOT-563









Internal Schematic

TOP VIEW

BOTTOM VIEW

Maximum Ratings N-CHANNEL – Q_1 @T_A = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit
Drain Source Voltage	V _{DSS}	20	V
Gate-Source Voltage	V_{GSS}	±6	V
Drain Current (Note 1) $ T_A = 25^{\circ}C $ $ T_A = 85^{\circ}C $	In In	870 630	mA

Maximum Ratings P-CHANNEL − Q₂ @T_A = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit
Drain Source Voltage	V_{DSS}	-20	V
Gate-Source Voltage	V_{GSS}	±6	V
Drain Current (Note 1) $ T_A = 25^{\circ}C $ $ T_A = 85^{\circ}C $	l ln	-640 -460	mA

Thermal Characteristics @TA = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 1)	P_{D}	530	mW
Thermal Resistance, Junction to Ambient (Note 1)	$R_{ hetaJA}$	235	°C/W
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C

Notes:

- 1. Device mounted on FR-4 PCB.
- 2. No purposefully added lead.
- 3. Diodes Inc.'s "Green" policy can be found on our website at http://www.diodes.com/products/lead_free/index.php.



Electrical Characteristics N-CHANNEL – Q₁ @T_A = 25°C unless otherwise specified

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 4)							
Drain-Source Breakdown Voltage	BV _{DSS}	20		_	V	$V_{GS} = 0V, I_D = 250 \mu A$	
Zero Gate Voltage Drain Current	I _{DSS}	_	_	100	nA	$V_{DS} = 20V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	_	_	± 1.0	μΑ	$V_{GS} = \pm 4.5V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(th)}	0.5	_	1.0	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$	
		_	0.3	0.4		$V_{GS} = 4.5V, I_D = 600mA$	
Static Drain-Source On-Resistance	R _{DS} (ON)	_	0.4	0.5	Ω	$V_{GS} = 2.5V, I_D = 500mA$	
		_	0.5	0.7		$V_{GS} = 1.8V, I_D = 350mA$	
Forward Transfer Admittance	Y _{fs}	_	1.4	_	S	$V_{DS} = 10V, I_D = 400mA$	
Diode Forward Voltage (Note 4)		_	0.7	1.2	V	$V_{GS} = 0V, I_{S} = 150mA$	
DYNAMIC CHARACTERISTICS							
Input Capacitance	C _{iss}	_	60.67	_	pF		
Output Capacitance	Coss	_	9.68	_	pF	$V_{DS} = 16V, V_{GS} = 0V$ -f = 1.0MHz	
Reverse Transfer Capacitance	C _{rss}	_	5.37	_	pF	-1 = 1.0IVIDZ	
Total Gate Charge	Qq		736.6	_		1, 15)/)/ 10)/	
Gate-Source Charge			93.6	_	рC	$V_{GS} = 4.5V, V_{DS} = 10V,$	
Gate-Drain Charge	Q _{gs} Q _{qd}	_	116.6	_		$I_D = 250 \text{mA}$	
Turn-On Delay Time	t _{d(on)}		5.1	_		10)/)/ 45)/	
Turn-On Rise Time	t _r		7.4	_		$V_{DD} = 10V, V_{GS} = 4.5V,$	
Turn-Off Delay Time	t _{d(off)}	_	26.7	_	ns	$R_L = 47\Omega$, $R_G = 10\Omega$, $I_D = 200$ mA	
Turn-Off Fall Time	t _f		12.3	_		ID = ZUUIIIA	

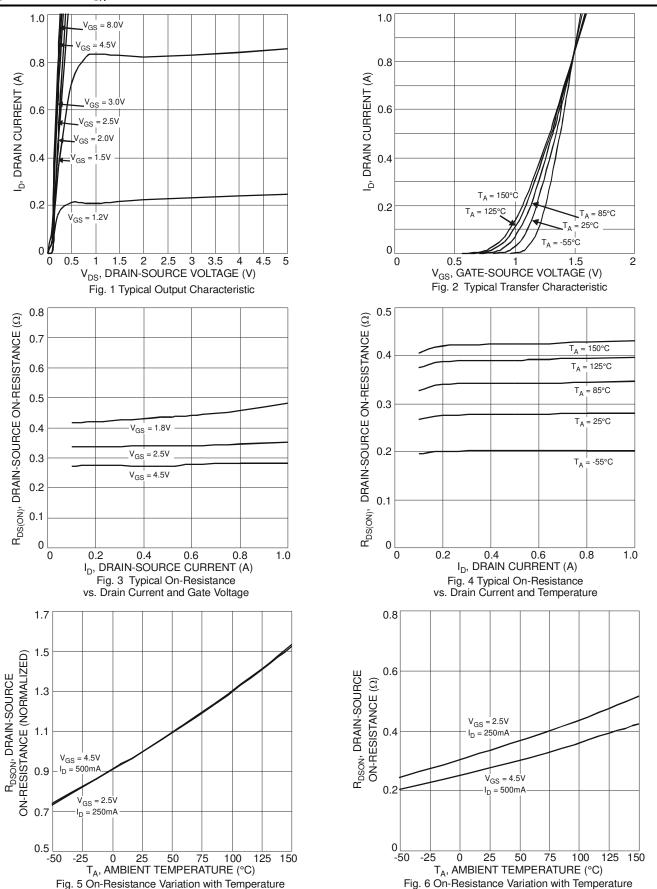
Electrical Characteristics P-CHANNEL - Q₂ @T_A = 25°C unless otherwise specified

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition		
OFF CHARACTERISTICS (Note 4)								
Drain-Source Breakdown Voltage	BV _{DSS}	-20		_	V	$V_{GS} = 0V, I_D = -250 \mu A$		
Zero Gate Voltage Drain Current	I _{DSS}			-100	nA	$V_{GS} = 0V, V_{GS} = 0V$ $V_{DS} = -20V, V_{GS} = 0V$		
Gate-Source Leakage	I _{GSS}			± 2.0	μА	$V_{GS} = \pm 4.5V, V_{DS} = 0V$		
ON CHARACTERISTICS (Note 4)	I IGSS			⊥ ∠.∪	μΛ	VGS = 14.0V, VDS - 0V		
Gate Threshold Voltage	V _{GS(th)}	-0.5	_	-1.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$		
outo milionote i sittige	- GO(iii)		0.5	0.7	-	$V_{GS} = -4.5V$, $I_{D} = -430$ mA		
Static Drain-Source On-Resistance	R _{DS (ON)}	_	0.7	0.9	Ω	$V_{GS} = -2.5V$, $I_D = -300$ mA		
	20 (0.1)		1.0	1.3		$V_{GS} = -1.8V, I_D = -150mA$		
Forward Transfer Admittance	Y _{fs}	_	-0.9	_	S	V _{DS} =10V, I _D = -250mA		
Diode Forward Voltage (Note 4)	V _{SD}	_	-0.8	-1.2	V	$V_{GS} = 0V, I_{S} = -150mA$		
DYNAMIC CHARACTERISTICS			I.	I				
Input Capacitance	C _{iss}	_	59.76	_	pF			
Output Capacitance	Coss	_	12.07	_	pF	$V_{DS} = -16V, V_{GS} = 0V$ -f = 1.0MHz		
Reverse Transfer Capacitance	C _{rss}	_	6.36	_	pF	T = 1.UIVIDZ		
Total Gate Charge	Qg	_	622.4	_		\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\		
Gate-Source Charge	Q _{gs}	_	100.3	_	рC	$V_{GS} = -4.5V, V_{DS} = -10V,$ $I_{D} = -250mA$		
Gate-Drain Charge	Q _{gd}	_	132.2	_		ID = -500MA		
Turn-On Delay Time	t _{d(on)}	_	5.1	_				
Turn-On Rise Time	t _r		8.1	_	ns	$V_{DD} = -10V, V_{GS} = -4.5V,$ $R_{L} = 47\Omega, R_{G} = 10\Omega,$		
Turn-Off Delay Time	t _{d(off)}	_	28.4	_	115	$R_L = 4752, R_G = 1052,$ $I_D = -200 \text{mA}$		
Turn-Off Fall Time	t _f	_	20.7	_		ID = -200IIIA		

Notes: 4. Short duration pulse test used to minimize self-heating effect.

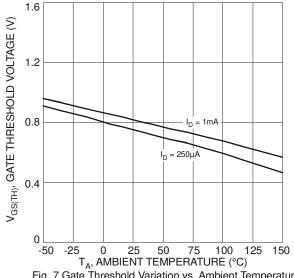


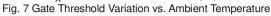
N-CHANNEL - Q₁

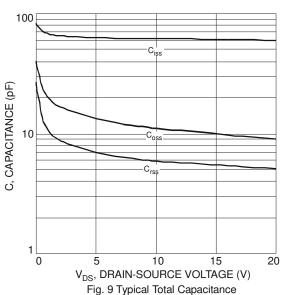


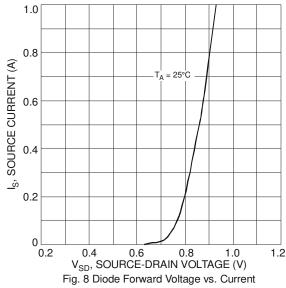


N-CHANNEL - Q₁ (continued)









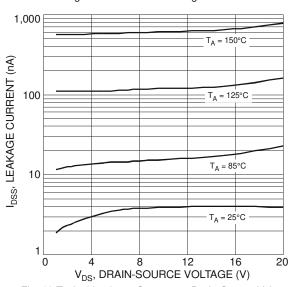


Fig. 10 Typical Leakage Current vs. Drain-Source Voltage

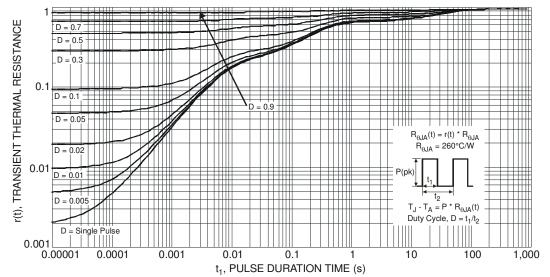
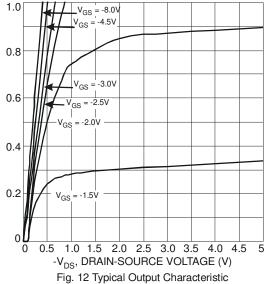
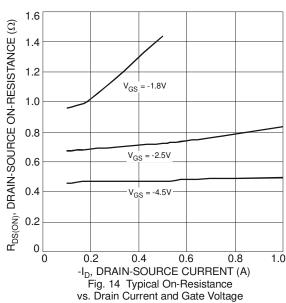


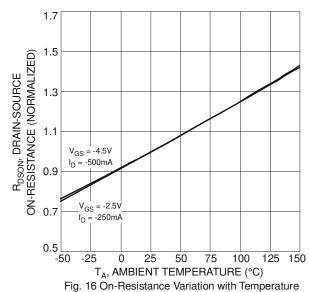
Fig. 11 Transient Thermal Response



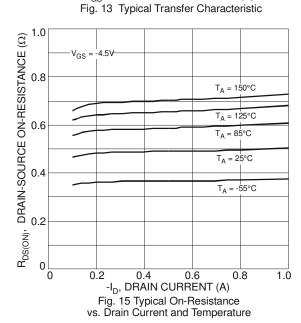
P-CHANNEL - Q₂

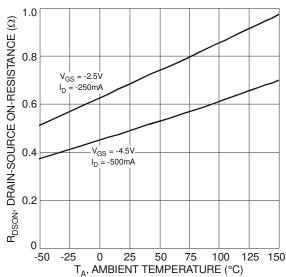






1.0 V_{DS} = -5V 0.8 V_{DS} = -5V 0.8 V_{DS} = -5V 0.8 V_{DS} = -5V 0.9 T_A = 150°C T_A = 150°C T_A = 25°C T_A = -55°C 0 0.5 1.0 1.5 2.0 2.5 3.0 -V_{GS}, GATE-SOURCE VOLTAGE (V)







P-CHANNEL - Q₂ (continued)

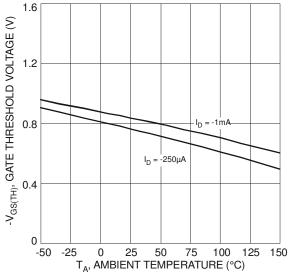
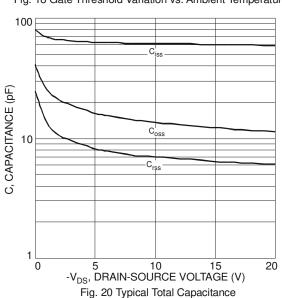


Fig. 18 Gate Threshold Variation vs. Ambient Temperature



1.0

(V)

0.8

0.6

0.6

0.7

0.2

0.4

0.6

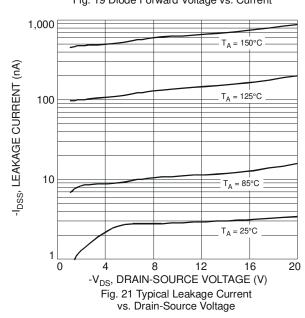
0.8

1.0

1.2

-V_{SD}, SOURCE-DRAIN VOLTAGE (V)

Fig. 19 Diode Forward Voltage vs. Current



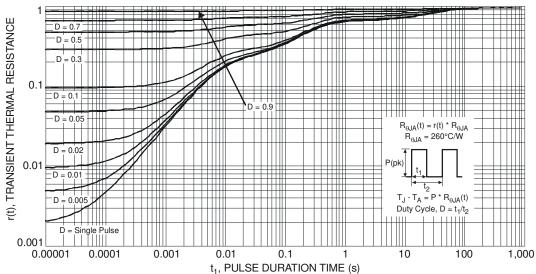


Fig. 22 Transient Thermal Response

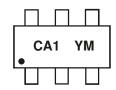


Ordering Information (Note 5)

Part Number	Case	Packaging
DMG1016V-7	SOT-563	3000/Tape & Reel

Notes: 5. For packaging details, go to our website at http://www.diodes.com/datasheets/ap02007.pdf.

Marking Information



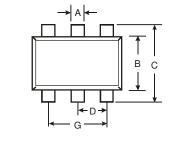
CA1 = Product Type Marking Code YM = Date Code Marking

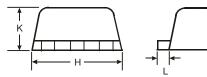
Y = Year (ex: W = 2009) M = Month (ex: 9 = September)

Date Code Key

Year	2009	9	2010		2011	20	12	2013		2014	2	2015
Code	W		Х		Υ	2	7	Α		В		С
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D

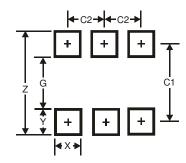
Package Outline Dimensions





SOT-563							
Dim	Min	Max	Тур				
Α	0.15	0.30	0.20				
В	1.10	1.25	1.20				
С	1.55	1.70	1.60				
D	-	-	0.50				
G	0.90	1.10	1.00				
Н	1.50	1.70	1.60				
K	0.55	0.60	0.60				
L	0.10	0.30	0.20				
M	0.10	0.18	0.11				
All	Dimens	sions in	mm				

Suggested Pad Layout



Dimensions	Value (in mm)
Z	2.2
G	1.2
Х	0.375
Υ	0.5
C1	1.7
C2	0.5



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